

Search Notes

Application/Control No.

10/642,477

Examiner

Jeffrey G. Hoekstra

Applicant(s)/Patent under
Reexamination

KAWAI ET AL.

Art Unit

3736

SEARCHED

Class	Subclass	Date	Examiner
600	587	1/11/2006	JGH
600	595	1/11/2006	JGH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR